Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2159	(703/13-17).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:45
L2	10412	(714/724-746).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:46
L3	23	eda and ((event adj5 vector) and (design adj3 data))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:46
L4	8	1 and 3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:46
L5	1	2 and 3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:46
S1	7668	eda	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:45
S2	51	prototype adj silicon	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/08 16:34
<b>S3</b> .	1624	event adj5 vector	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/20 16:00
S4	18451	design adj3 data	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/20 16:01
S5	4	modify\$3 adj5 event adj5 vector	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/20 16:05

S6	5	(prototype adj silicon) and (event adj5 vector)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/20 16:08
<b>S</b> 7	21	(prototype adj silicon) and (design adj3 data)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/20 16:10
S8	40	(event adj5 vector) and (design adj3 data)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/20 16:10
59	23	eda and ((event adj5 vector) and (design adj3 data))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON ,	2006/02/14 07:46
S10	166	event adj3 test adj4 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/08 17:12
S11	112	prototype adj3 silicon	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/08 16:34
S12	7717	eda	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/08 16:34
S13	5	(event adj3 test adj4 system) and (prototype adj3 silicon)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/08 16:37
S14	17	(event adj3 test adj4 system) and eda	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/08 16:37
S15	12	modify\$3 same (event adj3 test adj4 system)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/08 17:13

S16	8	eda and (prototype adj silicon)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/10/13 10:31
S17	9160	eda	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/09 09:59
S18	6	(event same test same vector same timing same difference same adjacent)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/09 10:05
S19	0	S17 and S18	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/09 10:05
S20	1629778	modif\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/09 10:06
S21	6	S18 and S20	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/09 10:06
S22	3021	(716/4-5).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:39
S23	2075	(714/736,738).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:39
S24	554	(703/16,17,20).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/14 07:40

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	(validat\$3 and design and silicon and electronic and automation and test and vector and prototype and modify\$3 and event and response). clm.	US-PGPUB	OR	ON	2006/02/14 07:44